

## **Supporting Information for**

### **Photocatalytic nitrogen fixation of metal-organic frameworks (MOFs) excited by ultraviolet light: Insights into the nitrogen fixation mechanism of missing metal cluster or linker defects**

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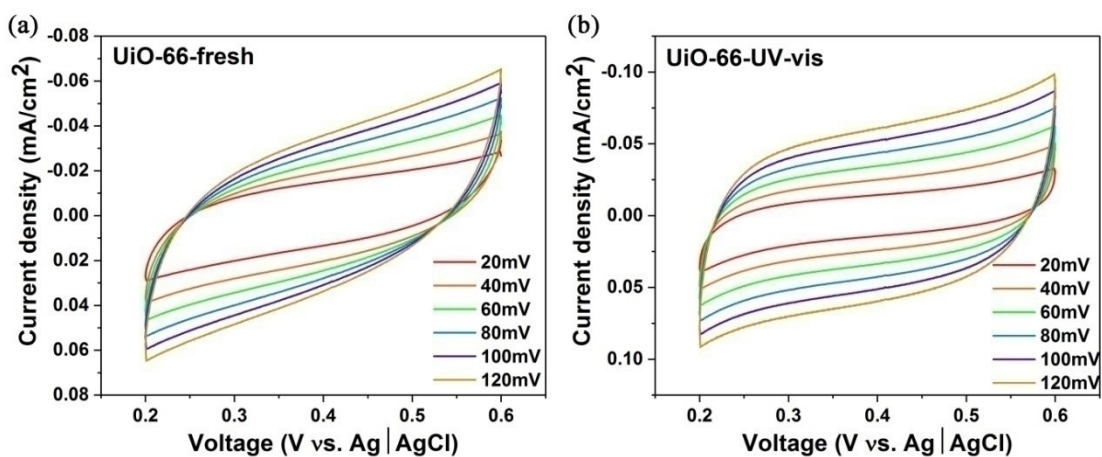
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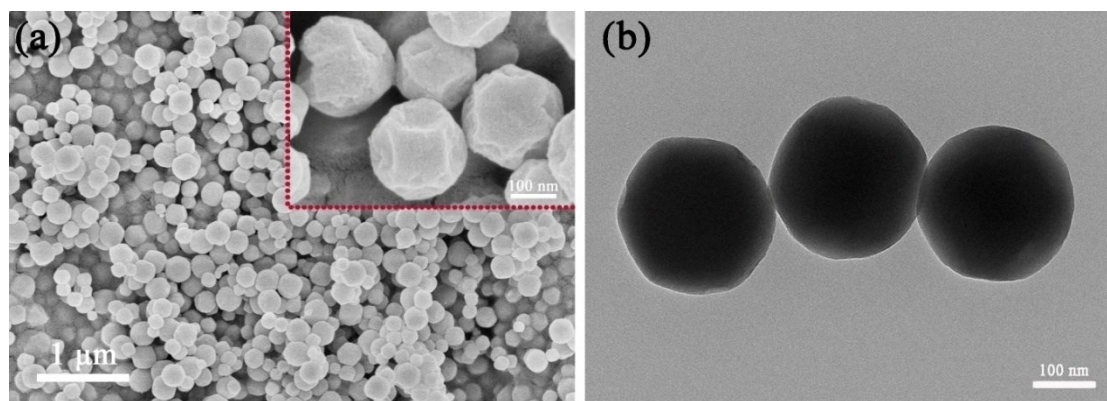
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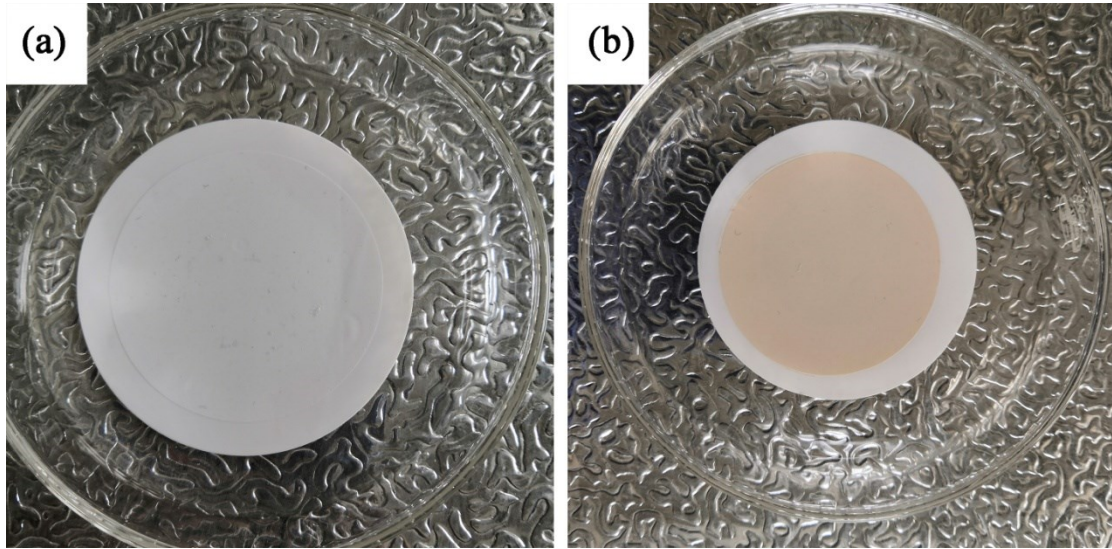


**Figure S1.** The cyclic voltammetry (CV) curves patterns of (a) UiO-66-fresh and (b) UiO-66-UV-vis at the scan rates range from 20 to 120 mV/s.

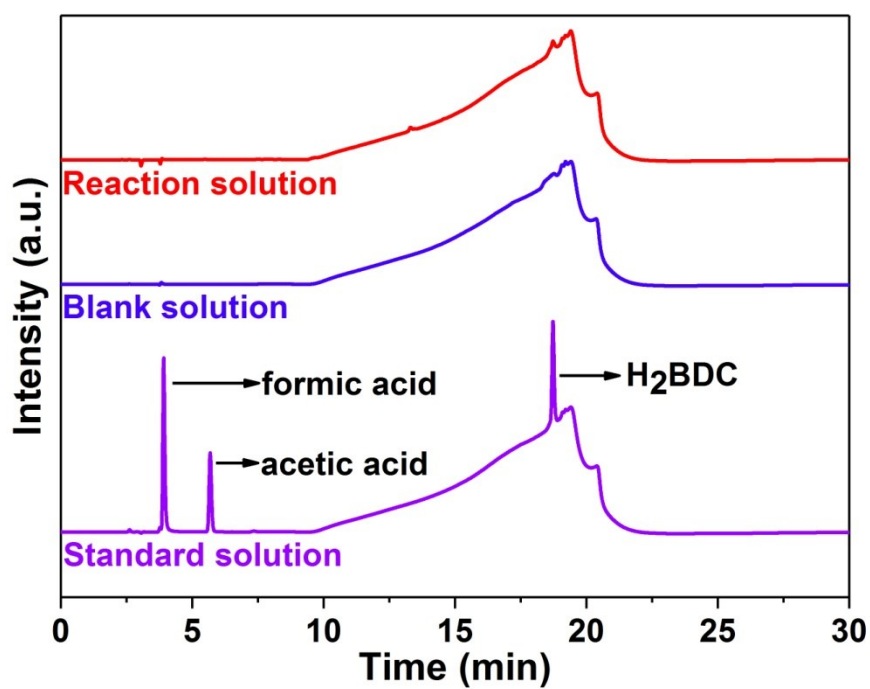
In the typical ECSA test, the surface area of a material is analyzed rely on electrochemical double layer capacitance ( $C_{dl}$ ), which could be performed by cyclic voltammetry (CV). Therefore, the  $C_{dl}$  values were derived from CV curves using the halves of the positive current density differences at the center point of their potential ranges.



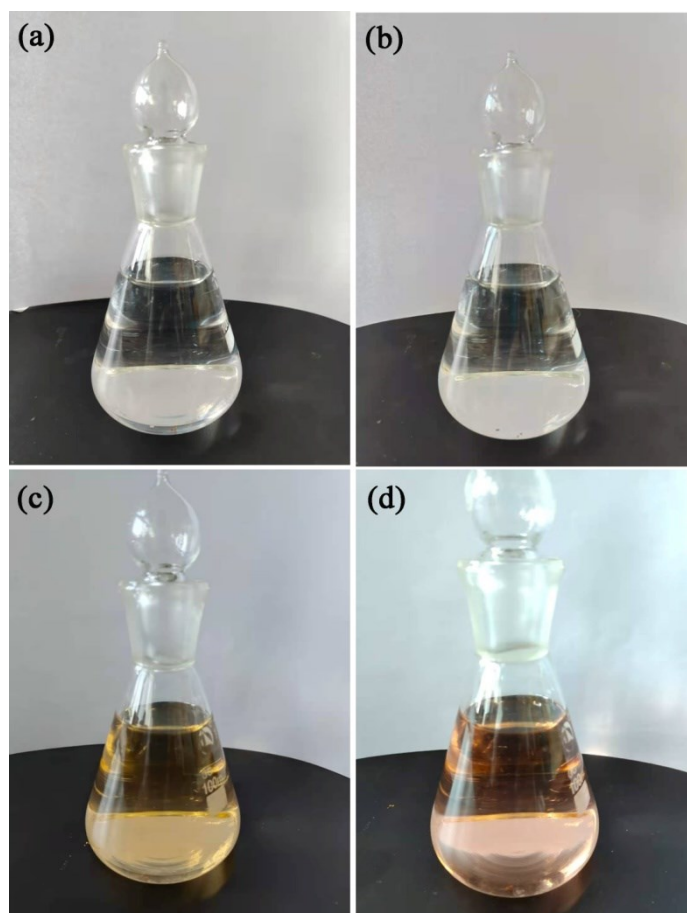
**Figure S2.** (a) SEM images and (b) TEM images of UiO-66-UV-vis.



**Figure S3.** The photo of (a) UiO-66-fresh and (b) UiO-66-UV-vis.

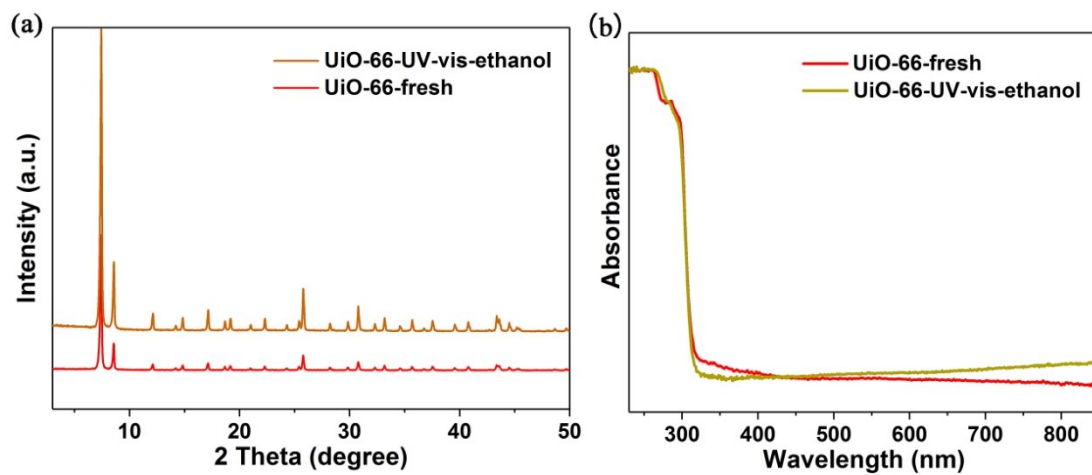


**Figure S4.** High performance liquid chromatography (HPLC) spectrum of the first photocatalytic solution.

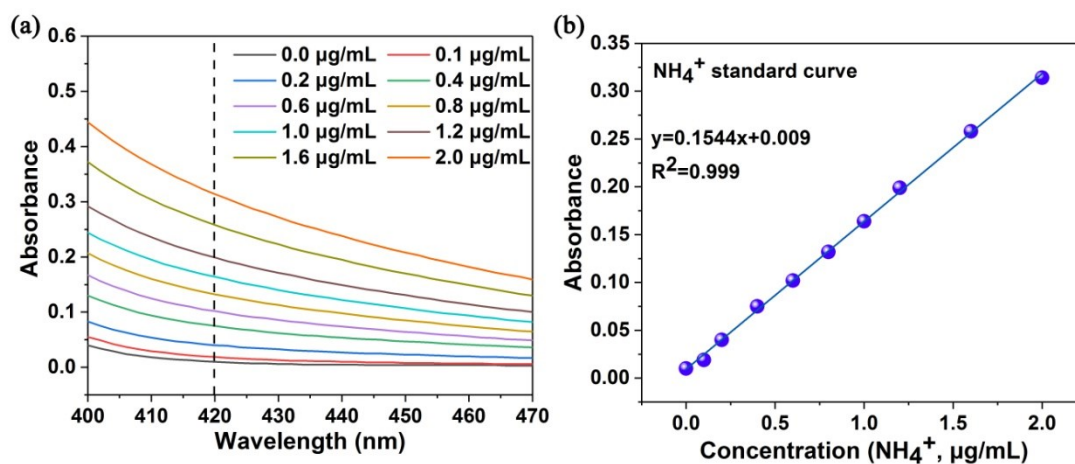


**Figure S5.** Standard titration method for determination of  $\text{HCO}_3^-$  or  $\text{CO}_3^{2-}$ : (a) adding phenolphthalein indicator (colorless), (b) not adding hydrochloric acid (colorless), (c) adding methyl orange indicator (orange-yellow), and (d) adding hydrochloric acid (orange-red).



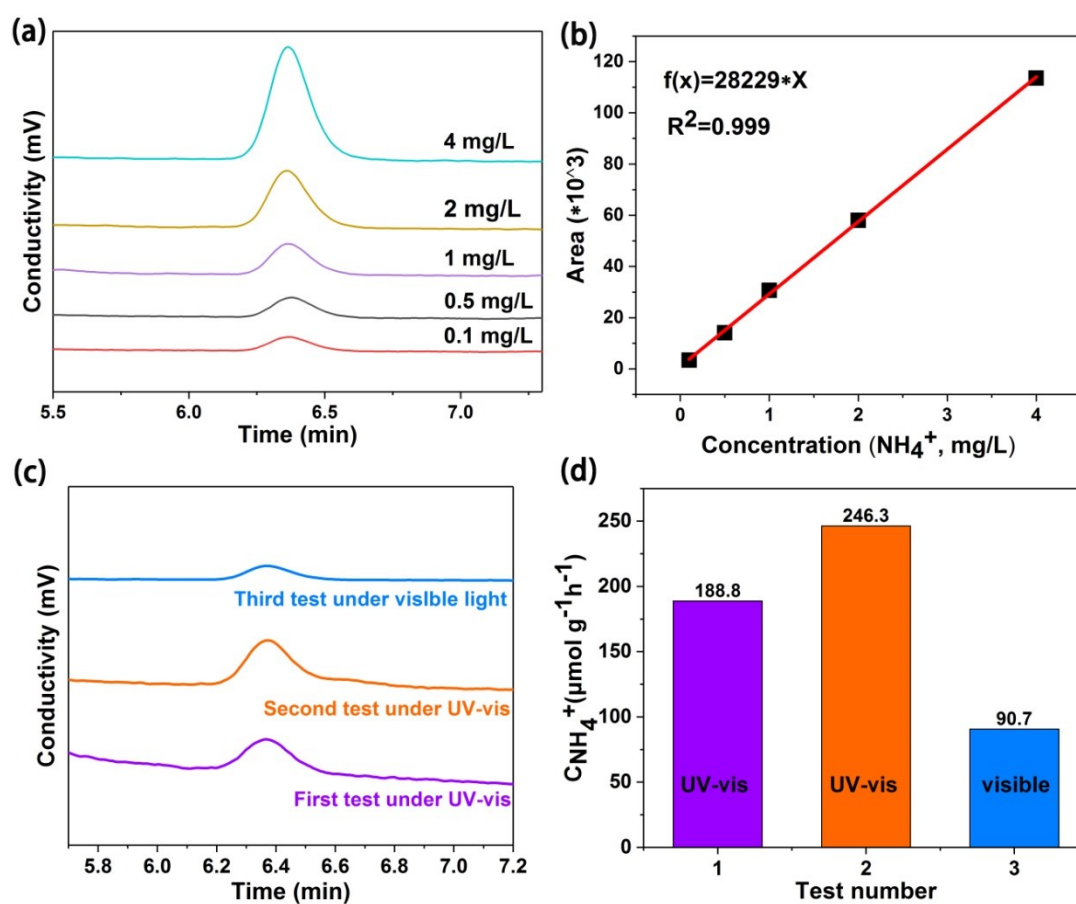


**Figure S6.** XRD and UV-vis DRS of UiO-66-UV-vis-ethanol and UiO-66-fresh.

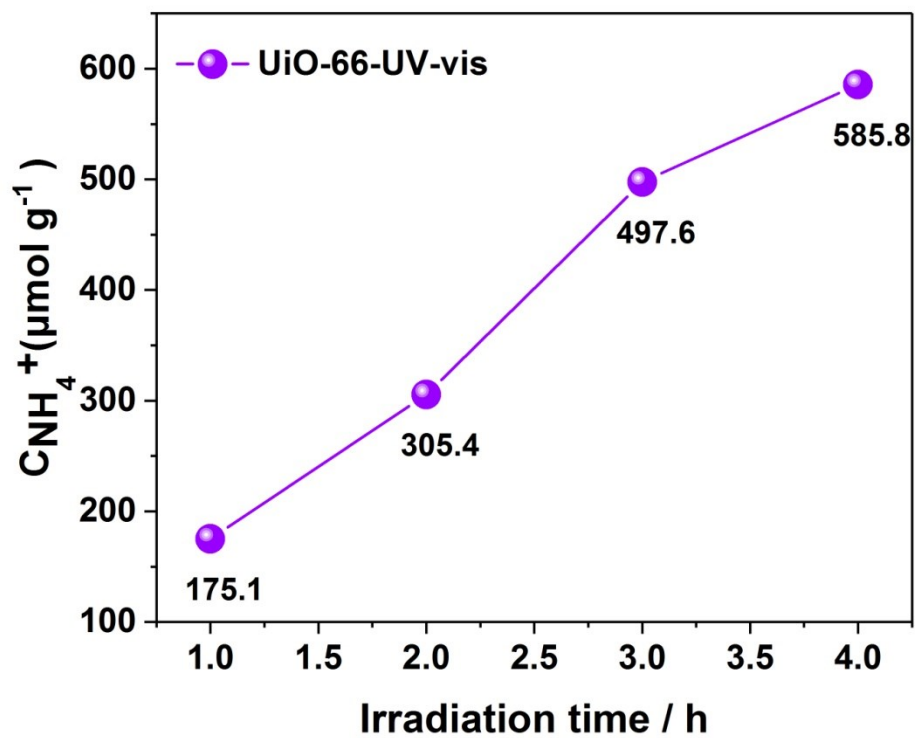


**Figure S7.** (a) UV-Vis absorption curves of different concentrations of  $\text{NH}_4^+$  ions tested by Nessler's reagent method, (b) A calibration curve used to estimate the concentrations of  $\text{NH}_4^+$  ions.

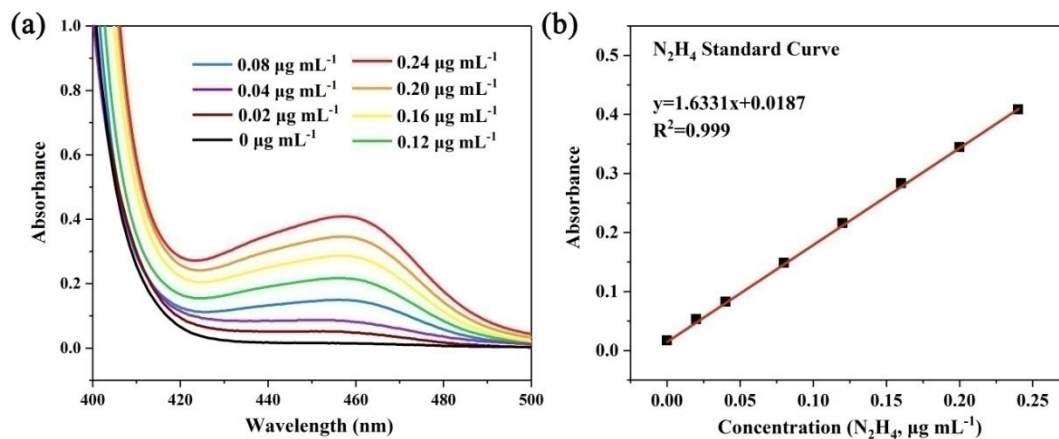
The fitting curve ( $y = 0.1544x + 0.009$ ,  $R^2 = 0.999$ ) shows good linear relationship between the absorbance value and the  $\text{NH}_4^+$  concentration.



**Figure S8.** (a) Ion chromatograms of  $\text{NH}_4^+$  with different concentrations in ultrapure water, (b) A calibration curve, (c) Ion chromatogram data for the solution at different light irradiation under  $\text{N}_2$  ambient potentials, and (d)  $\text{NH}_3$  yields calculated by ion chromatography.

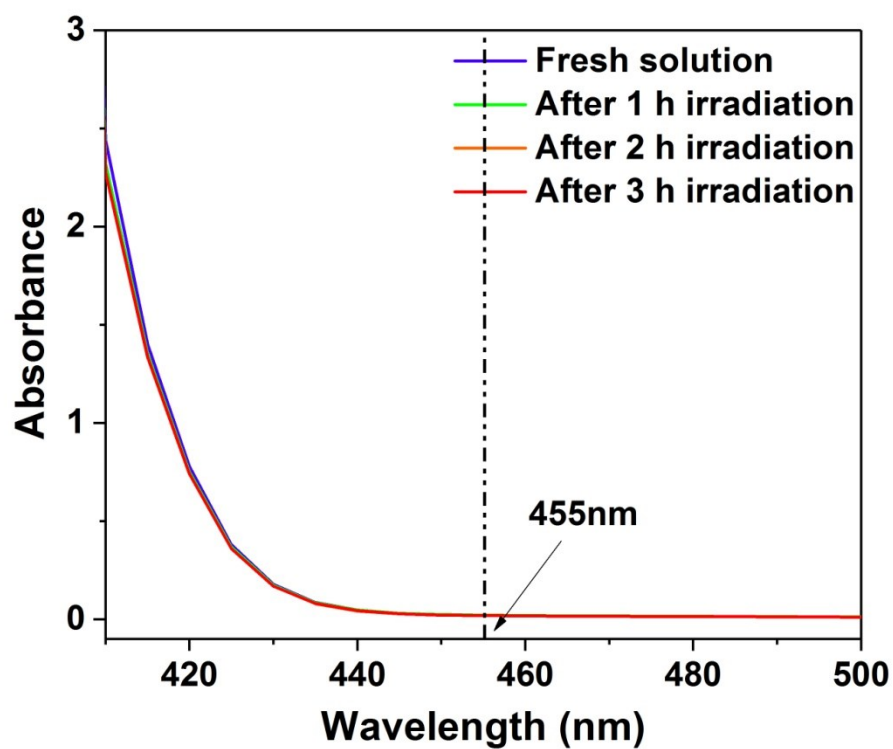


**Figure S9.**  $\text{NH}_4^+$  production rate of activated UiO-66 along with the reaction time.

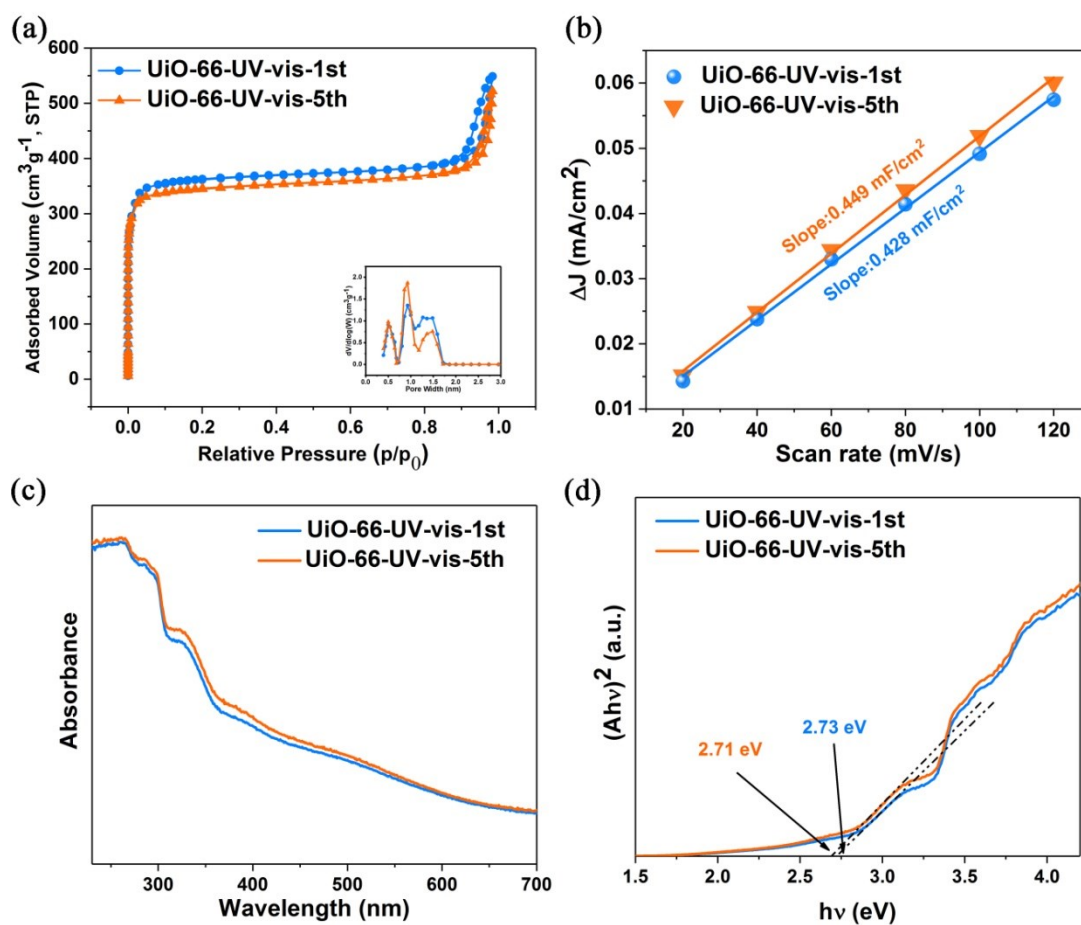


**Figure S10.** (a) UV-Vis absorption curves of various concentrations of  $N_2H_4$  stained with  $p-C_9H_{11}NO$  indicator, (b) A calibration curve used to estimate the concentrations of  $N_2H_4$ .

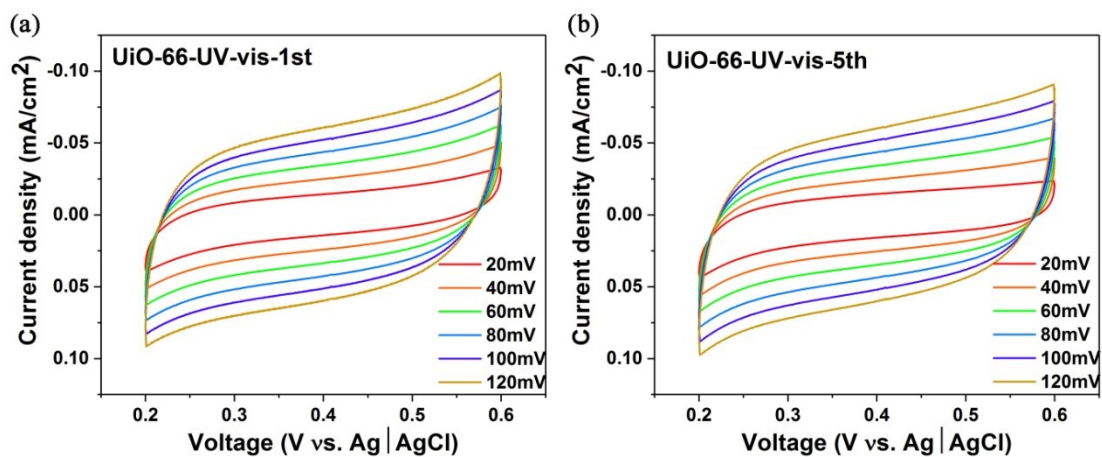
The fitting curve ( $y = 1.6331x + 0.0187$ ,  $R^2 = 0.999$ ) shows a good linear relation of absorbance value with  $N_2H_4$  concentration.



**Figure S11.** UV-Vis absorption spectra of the solution stained with p-C<sub>9</sub>H<sub>11</sub>NO indicator after photocatalytic nitrogen fixation different time.



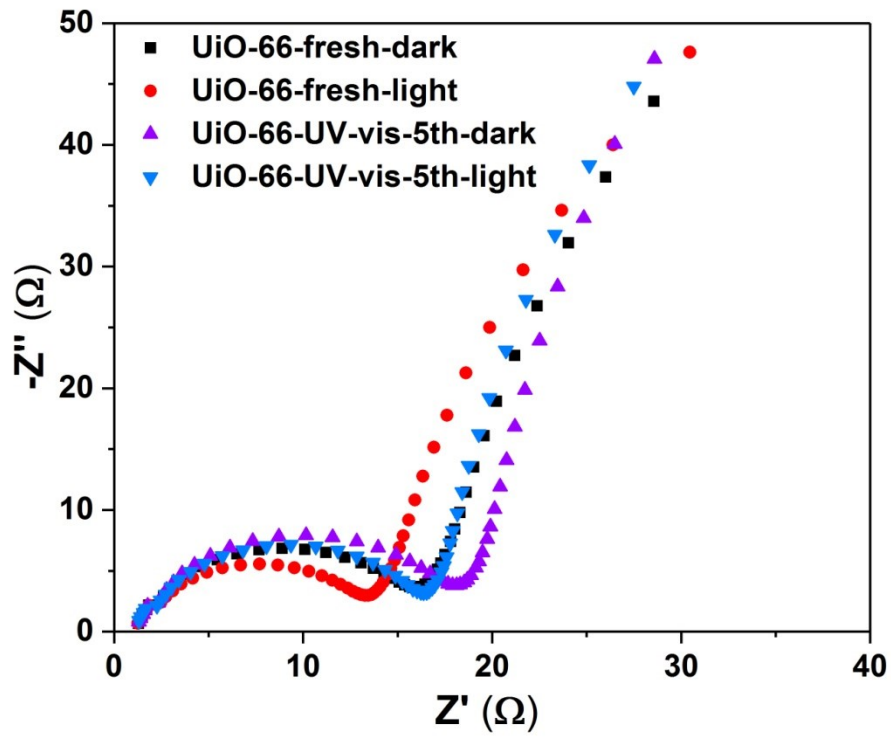
**Figure S12.** (a) N<sub>2</sub> adsorption-desorption isotherms, (b) Plot of the scan rates against the differences in the double layer charging current, (c) UV-vis DRS, and (d) Tauc plots of UiO-66-UV-vis-1st and UiO-66-UV-vis-5th.



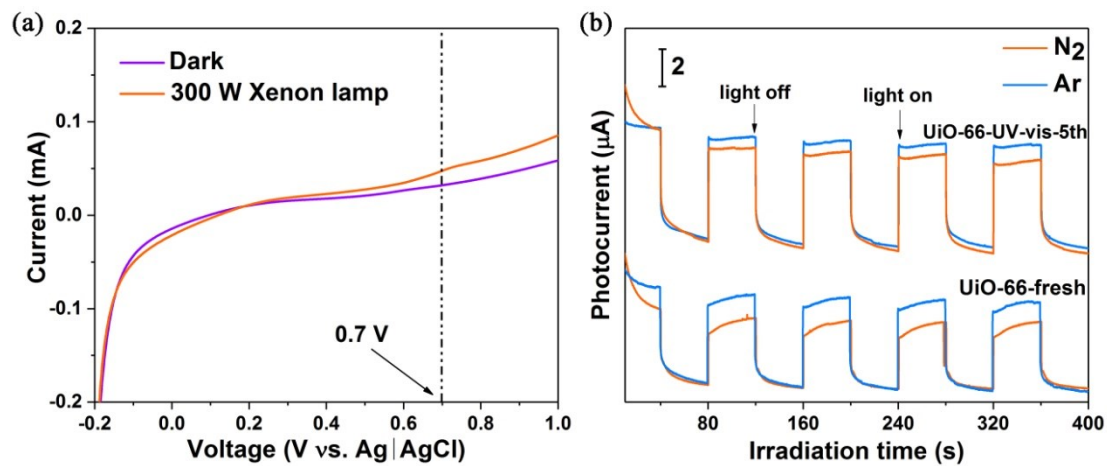
**Figure S13.** The cyclic voltammetry (CV) curves patterns of (a) UiO-66-UV-vis-1st and (b) UiO-66-UV-vis-5th at the scan rates range from 20 to 120 mV/s.

The calculation process is the same as Figure S1.



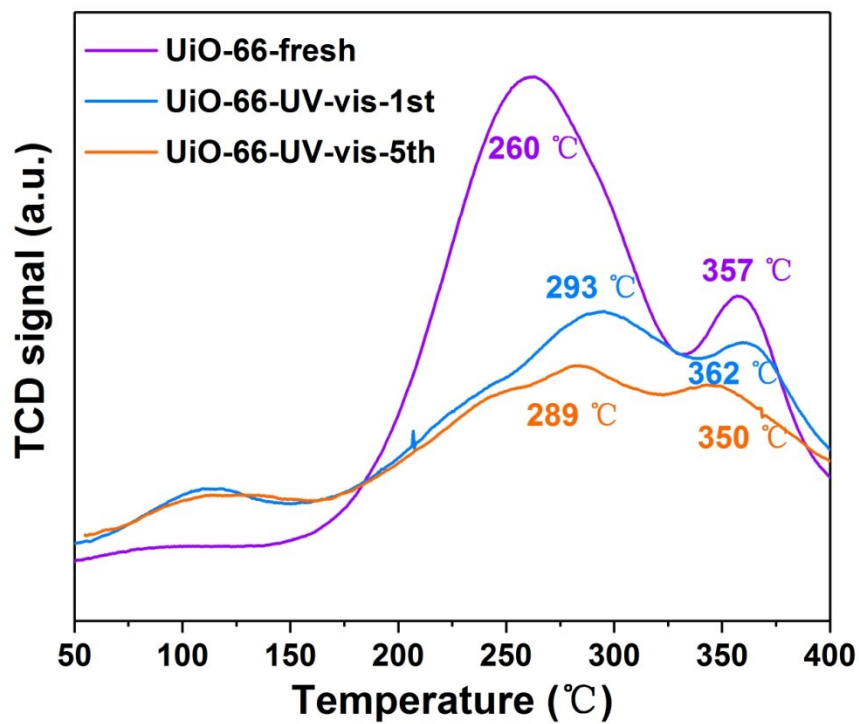


**Figure S14.** Electrochemical impedance spectra (EIS) of UiO-66-fresh and UiO-66-UV-vis-5th under dark and light conditions.

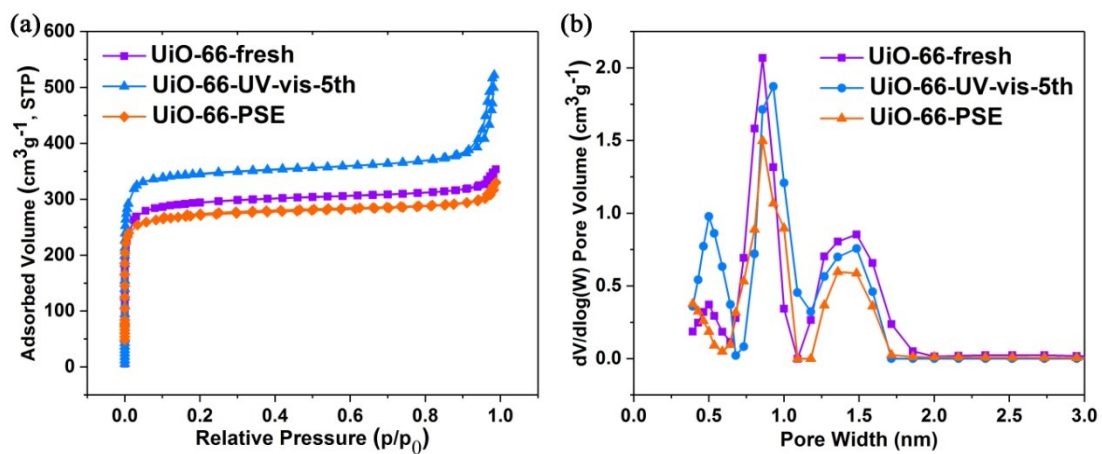


**Figure S15.** (a) Linear sweep voltammetry (LSV) spectra of the UiO-66 under dark condition and 300 W Xenon light irradiation in  $\text{N}_2$  ambient, and (b) Photocurrent spectra of UiO-66-fresh and UiO-66-UV-vis-5th.

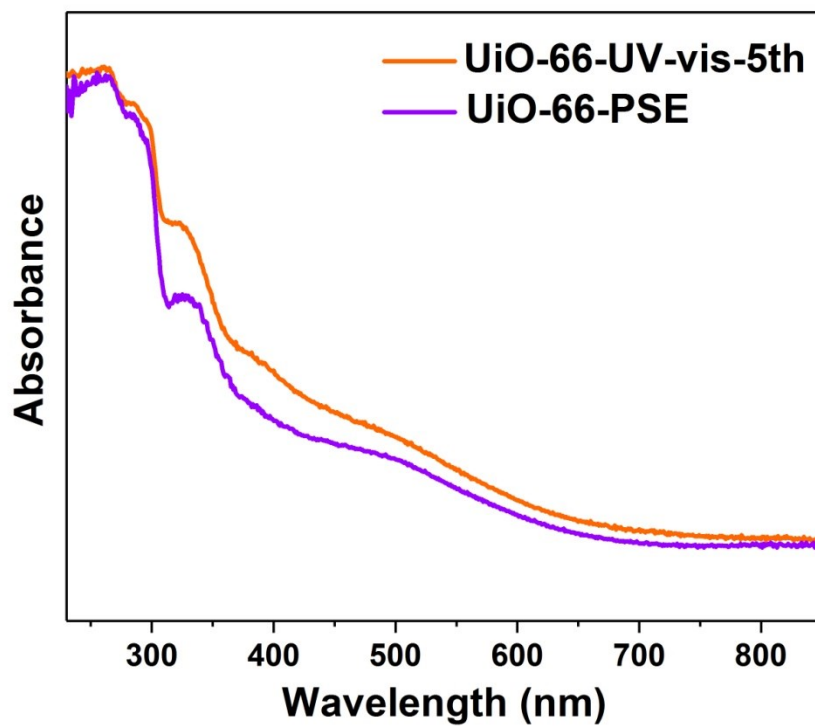
Before the photocurrent measurements, the linear sweep voltammetry test was conducted under dark condition and 300 W Xenon light irradiation in  $\text{N}_2$  ambient to determine the bias voltage was 0.7 V.



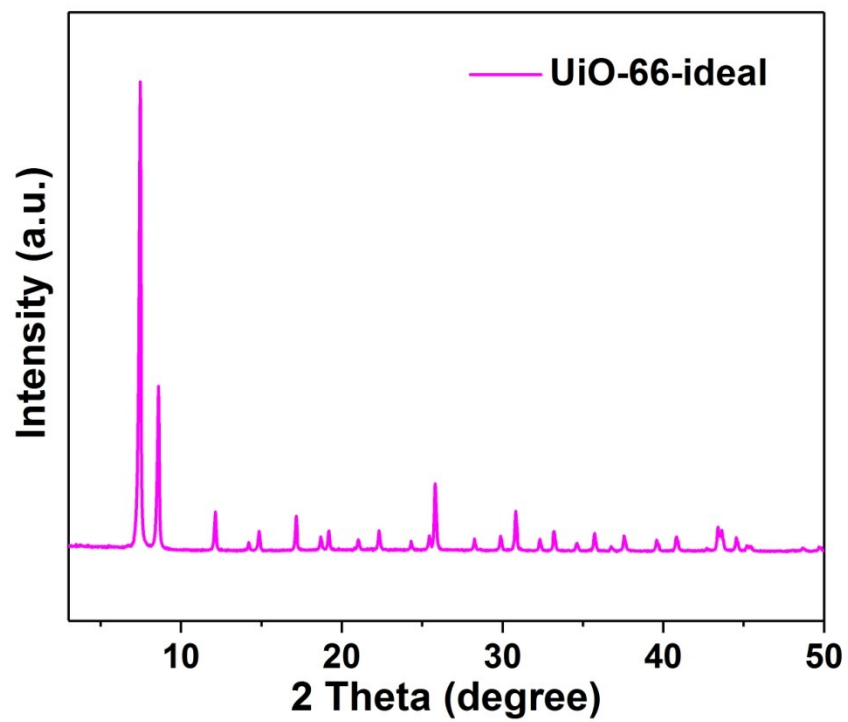
**Figure S16.** N<sub>2</sub>-TPD spectra of UiO-66-fresh, UiO-66-UV-vis-1st, and UiO-66-UV-vis-5th.



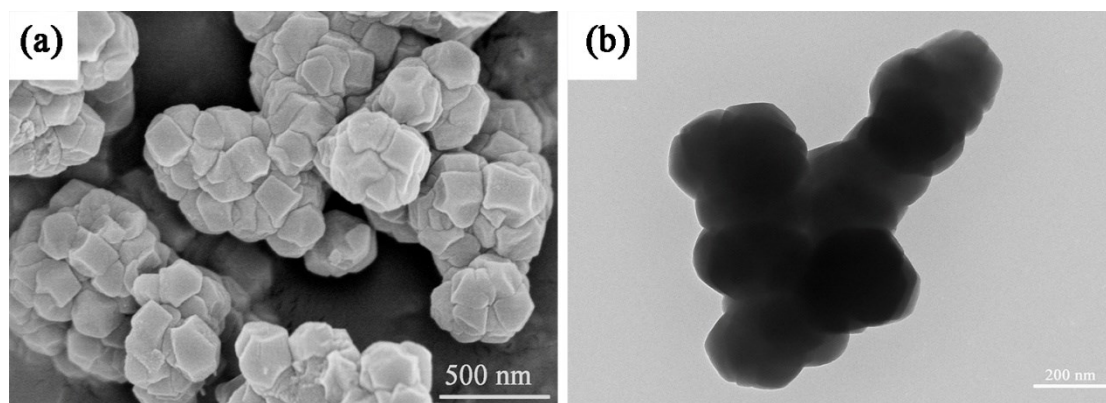
**Figure S17.** (a)  $N_2$  adsorption-desorption isotherms, and (b) pore size distribution curves of UiO-66-fresh and UiO-66-UV-vis-5th and UiO-66-PSE.



**Figure S18.** The UV-vis diffuse reflectance spectra (UV-vis DRS) of UiO-66-UV-vis-5th and UiO-66-PSE.



**Figure S19.** XRD pattern of UiO-66-ideal.



**Figure S20.** (a) Scanning electron microscopy (SEM) images and (b) Transmission electron microscopy (TEM) images of UiO-66-ideal.

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**Table S1** Comparison of physical properties of the samples

Photocatalyst	Surface area ( $\text{m}^2 \cdot \text{g}^{-1}$ )	Mean pore diameter (nm)	Total pore volume ( $\text{cm}^3 \cdot \text{g}^{-1}$ )
UiO-66-fresh	995	2.12	0.416
UiO-66-UV-vis (UiO-66-UV-vis-1st)	1225	2.77	0.519
UiO-66-UV-vis-5th	1144	2.82	0.493
UiO-66-ideal	819	2.10	0.388



**Table S2** Comparison of nitrogen photofixation rate with various MOF photocatalysts

Photocatalyst	Reaction medium	Scavenger	Light source	Nitrogen source	NH <sub>3</sub> yield	Reference
<b>UiO-66</b>	<b>H<sub>2</sub>O</b>	<b>No</b>	<b>UV-vis</b> <b>λ ≥ 420 nm</b>	<b>N<sub>2</sub></b>	<b>256 μmol g<sup>-1</sup> h<sup>-1</sup></b>	<b>This work</b>
				<b>Air</b>	<b>196 μmol g<sup>-1</sup> h<sup>-1</sup></b>	
				<b>N<sub>2</sub></b>	<b>97 μmol g<sup>-1</sup> h<sup>-1</sup></b>	
				<b>Air</b>	<b>70 μmol g<sup>-1</sup> h<sup>-1</sup></b>	
Ti <sub>3</sub> C <sub>2</sub> -QD/Ni-MOF	H <sub>2</sub> O+ NaSO <sub>3</sub>	1 mM NaSO <sub>3</sub>	UV-vis	N <sub>2</sub>	88.79 μmol g <sup>-1</sup> h <sup>-1</sup>	1
MIL-53 (Fe II/Fe III)	H <sub>2</sub> O+ K <sub>2</sub> SO <sub>3</sub>	0.158 g/L K <sub>2</sub> SO <sub>3</sub>	λ ≥ 420 nm	N <sub>2</sub>	306 μmol g <sup>-1</sup> h <sup>-1</sup>	2
Gd-IHEP-7	H <sub>2</sub> O	No	UV-vis	N <sub>2</sub>	128 μmol g <sup>-1</sup> h <sup>-1</sup>	3
Gd-IHEP-8					220 μmol g <sup>-1</sup> h <sup>-1</sup>	
g-C <sub>3</sub> N <sub>4</sub> /MOF-74 (Zn)	H <sub>2</sub> O+ Methanol	Methanol (4% wt)	λ ≥ 400 nm	Air	1.7 mmol g <sup>-1</sup> h <sup>-1</sup>	4
MIL-101 (Fe)	H <sub>2</sub> O	No	UV-vis	N <sub>2</sub>	100 μmol g <sup>-1</sup> h <sup>-1</sup>	5
NH <sub>2</sub> -MIL-125 (Ti)	H <sub>2</sub> O	No	λ ≥ 400 nm	N <sub>2</sub>	12.25 μmol g <sup>-1</sup> h <sup>-1</sup>	6
Ce-MOF	H <sub>2</sub> O	No	UV-vis	N <sub>2</sub>	34 μmol g <sup>-1</sup> h <sup>-1</sup>	7

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